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FORM PTO 1449 (modified)				ATTY DOCKET NO. 03500.017969	ATION NO. 15,323			
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		5,578,141	11/26/1996	Mori et al.	136	251		
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		5,684,325	11/04/1997	Kataoka et al.	257	433		
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6	£ 19	5,800,631	09/01/1998	Yamada et al.	136	251		
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wh		6,133,061	10/17/2000	Sonoda	438	69		
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W		3273294	02/01/2002	Japan			Abstract	
		10-140373	05/26/1998	Japan			Abstract	
		2001-152390	06/05/2001	Japan			Abstract	
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W .	]	4-119843	04/21/1992	Japan			Abstract	
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DATE CONSIDERED 4/11/2007

EXAMINER William

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FORM PTO 1449 (modified)			ATTY DOCKET NO. APPLICATION NO. 10/805,323			
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	6,113,718	09/05/2000	Yamada et al.	156	78	
	6,162,986	12/19/2000	Shiotsuka et al.	136	244	
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wh	6,488,995	12/03/2002	Nishimoto et al.	427	574	
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APPLICATION NO. ATTY DOCKET NO. FORM PTO 1449 (modified) 10/805,323 03500.017969 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **APPLICANT** MASUMITSU IWATA, ET AL. LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) GROUP FILING DATE 4753 Date submitted to PTO: August 18, 2004 March 22, 2004 U.S. PATENT DOCUMENTS FILING DATE DOCUMENT \*EXAMINER CLASS SUBCLASS IF APPROPRIATE NAME NUMBER DATE INITIAL WL 136 244 02/04/2003 Zenko et al. 6,515,216 438 609 04/08/2003 Sonoda et al. 6.544.877 06/10/2003 Sonoda et al. 205 155 6,576,112 438 73 Kondo et al. 6,653,165 11/25/2003 136 256 6,660,931 12/09/2003 Toyama et al. 6,664,597 12/16/2003 Takeyama et al. 257 347 136 251 6,693,237 02/17/2004 Zenko et al. 03/16/2004 Kondo et al. 427 588 6,706,336 2002/0117661 08/29/2002 Kondo et al. 257 21 705 50 2003/0028486 02/06/2003 Nakamura 257 64 Kondo et al. 2003/0075717 04/24/2003 438 200 2003/0104664 06/05/2003 Kondo et al. 08/14/2003 Kondo et al. 438 478 2003/0153165 W 427 04/08/2004 419.1 2004/0067321 Kondo et al. FOREIGN PATENT DOCUMENTS **TRANSLATION** SUBCLASS YES/NO/ OR ABSTRACT CLASS DATE COUNTRY DOCUMENT NUMBER OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) EXAMINER William Leader 4/11/2007 DATE CONSIDERED

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Sheet <u>1</u> of <u>1</u>

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE PE  LIST OF REFERENCES CITED BY APPECANT(S)  (Use several sheets if negessary)			ATTY DOCKET NO. 03500.017969.	APPLICATION NO.	10/805,323				
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